

Search Notes

Application/Control No.

10/617,690

Examiner

Jack Chiang

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2642

SEARCHED

Class	Subclass	Date	Examiner
379	433.13	8/11/2005	
455	575.3		
455	575.1		
348	340		
	<i>updated in above</i>	<i>OSmerob.</i>	<i>unZ</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR